

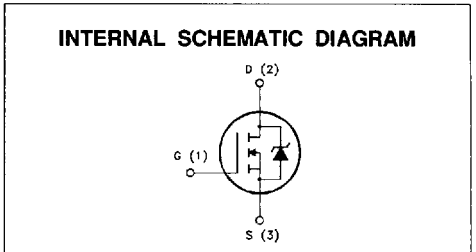
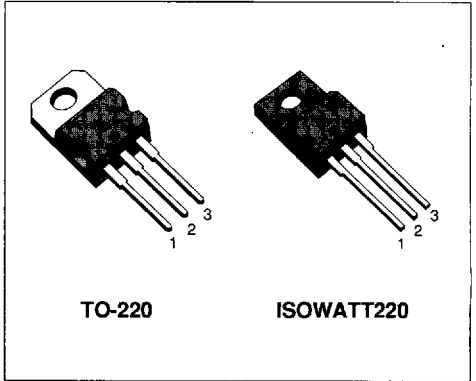
**N - CHANNEL ENHANCEMENT MODE  
POWER MOS TRANSISTOR**

| TYPE      | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-----------|------------------|---------------------|----------------|
| STP4N40   | 400 V            | < 2.1 Ω             | 4 A            |
| STP4N40FI | 400 V            | < 2.1 Ω             | 3 A            |

- TYPICAL R<sub>DS(on)</sub> = 1.65 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- APPLICATION ORIENTED CHARACTERIZATION

**APPLICATIONS**

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- CHOPPER REGULATORS, CONVERTERS, MOTOR CONTROL, LIGHTING FOR INDUSTRIAL AND CONSUMER ENVIRONMENT



**ABSOLUTE MAXIMUM RATINGS**

| Symbol              | Parameter   | Value      |           | Unit |
|---------------------|---|------------|-----------|------|
|                     |   | STP4N40    | STP4N40FI |      |
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)            | 400        |           | V    |
| V <sub>DGR</sub>    | Drain- gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 400        |           | V    |
| V <sub>GS</sub>     | Gate-source Voltage                                   | ± 20       |           | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 4          | 3         | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 2.5        | 1.9       | A    |
| I <sub>DM</sub> (*) | Drain Current (pulsed)                                | 16         | 16        | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C           | 75         | 35        | W    |
|                     | Derating Factor                                       | 0.6        | 0.28      | W/°C |
| V <sub>ISO</sub>    | Insulation Withstand Voltage (DC)                     | —          | 2000      | V    |
| T <sub>stg</sub>    | Storage Temperature                                   | -65 to 150 |           | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                   | 150        |           | °C   |

(\*) Pulse width limited by safe operating area

## THERMAL DATA

|                |  |     | TO-220 | ISOWATT220 |                             |
|----------------|--|-----|--------|------------|-----------------------------|
| $R_{thj-case}$ | Thermal Resistance Junction-case               | Max | 1.67   | 3.57       | $^{\circ}\text{C}/\text{W}$ |
| $R_{thj-amb}$  | Thermal Resistance Junction-ambient            | Max |        | 62.5       | $^{\circ}\text{C}/\text{W}$ |
| $R_{thc-sink}$ | Thermal Resistance Case-sink                   | Typ |        | 0.5        | $^{\circ}\text{C}/\text{W}$ |
| $T_j$          | Maximum Lead Temperature For Soldering Purpose |     |        | 300        | $^{\circ}\text{C}$          |

## AVALANCHE CHARACTERISTICS

| Symbol   | Parameter  | Max Value | Unit |
|----------|--|-----------|------|
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max, $\delta < 1\%$ )                                | 4         | A    |
| $E_{AS}$ | Single Pulse Avalanche Energy (starting $T_j = 25^{\circ}\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{V}$ )                      | 110       | mJ   |
| $E_{AR}$ | Repetitive Avalanche Energy (pulse width limited by $T_j$ max, $\delta < 1\%$ )  | 7         | mJ   |
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive ( $T_c = 100^{\circ}\text{C}$ , pulse width limited by $T_j$ max, $\delta < 1\%$ ) | 2.5       | A    |

ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}\text{C}$  unless otherwise specified)

OFF

| Symbol        | Parameter  | Test Conditions   | Min. | Typ. | Max.        | Unit                           |
|---------------|--|---|------|------|-------------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 250\ \mu\text{A}$ $V_{GS} = 0$   | 400  |      |             | V                              |
| $I_{DSS}$     | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating} \times 0.8$ $T_c = 125^{\circ}\text{C}$ |      |      | 250<br>1000 | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$     | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20\text{V}$   |      |      | $\pm 100$   | nA                             |

ON (\*)

| Symbol       | Parameter                         | Test Conditions  | Min. | Typ. | Max.       | Unit                 |
|--------------|-----------------------------------|--|------|------|------------|----------------------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 250\ \mu\text{A}$   | 2    | 3    | 4          | V                    |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 10\text{V}$ $I_D = 2\text{A}$<br>$V_{GS} = 10\text{V}$ $I_D = 2\text{A}$ $T_c = 100^{\circ}\text{C}$ |      | 1.65 | 2.1<br>4.2 | $\Omega$<br>$\Omega$ |
| $I_{D(on)}$  | On State Drain Current            | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$<br>$V_{GS} = 10\text{V}$   | 4    |      |            | A                    |

DYNAMIC

| Symbol       | Parameter                    | Test Conditions   | Min. | Typ. | Max. | Unit |
|--------------|------------------------------|---|------|------|------|------|
| $g_{fs} (*)$ | Forward Transconductance     | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 2\text{A}$ | 1    | 2.1  |      | S    |
| $C_{iss}$    | Input Capacitance            | $V_{DS} = 25\text{V}$ $f = 1\text{MHz}$ $V_{GS} = 0$        |      | 350  | 450  | pF   |
| $C_{oss}$    | Output Capacitance           |   |      | 68   | 90   | pF   |
| $C_{rss}$    | Reverse Transfer Capacitance |   |      | 32   | 45   | pF   |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING ON**

| Symbol         | Parameter             | Test Conditions   | Min. | Typ. | Max. | Unit       |
|----------------|-----------------------|---|------|------|------|------------|
| $t_{d(on)}$    | Turn-on Time          | $V_{DD} = 175\text{ V}$ $I_D = 2\text{ A}$  |      | 25   | 33   | ns         |
| $t_r$          | Rise Time             | $R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 3)   |      | 70   | 90   | ns         |
| $(di/dt)_{on}$ | Turn-on Current Slope | $V_{DD} = 320\text{ V}$ $I_D = 4\text{ A}$<br>$R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 5) |      | 110  |      | A/ $\mu$ s |
| $Q_g$          | Total Gate Charge     | $V_{DD} = 320\text{ V}$ $I_D = 4\text{ A}$ $V_{GS} = 10\text{ V}$   |      | 25   | 35   | nC         |
| $Q_{gs}$       | Gate-Source Charge    |   |      | 7    |      | nC         |
| $Q_{gd}$       | Gate-Drain Charge     |   |      | 11   |      | nC         |

**SWITCHING OFF**

| Symbol        | Parameter             | Test Conditions                            | Min. | Typ. | Max. | Unit |
|---------------|-----------------------|--|------|------|------|------|
| $t_{r(voff)}$ | Off-voltage Rise Time | $V_{DD} = 320\text{ V}$ $I_D = 4\text{ A}$ |      | 50   | 65   | ns   |
| $t_f$         | Fall Time             | $R_G = 50\ \Omega$ $V_{GS} = 10\text{ V}$  |      | 28   | 35   | ns   |
| $t_c$         | Cross-over Time       | (see test circuit, figure 5)               |      | 75   | 95   | ns   |

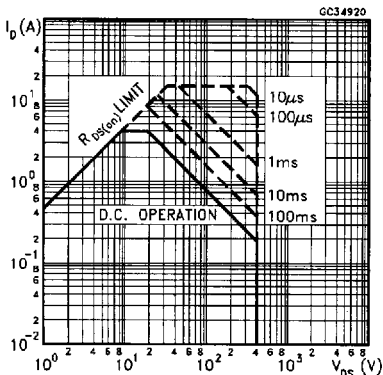
**SOURCE DRAIN DIODE**

| Symbol          | Parameter                     | Test Conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain Current          |   |      |      | 4    | A             |
| $I_{SDM}(\ast)$ | Source-drain Current (pulsed) |   |      |      | 16   | A             |
| $V_{SD}(\ast)$  | Forward On Voltage            | $I_{SD} = 4\text{ A}$ $V_{GS} = 0$  |      |      | 2    | V             |
| $t_{rr}$        | Reverse Recovery Time         | $I_{SD} = 4\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 100\text{ V}$ $T_j = 150\text{ }^\circ\text{C}$ |      | 400  |      | ns            |
| $Q_{rr}$        | Reverse Recovery Charge       | (see test circuit, figure 5)  |      | 5.9  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse Recovery Current      |   |      | 29.5 |      | A             |

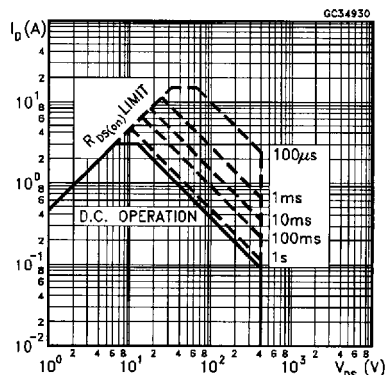
(\*) Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %

(\*) Pulse width limited by safe operating area

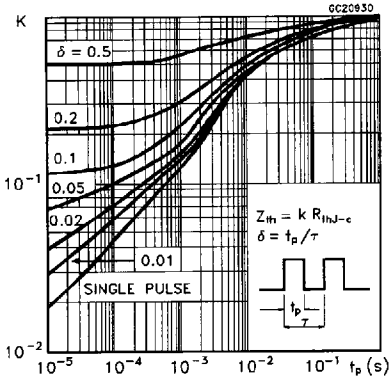
**Safe Operating Areas For TO-220**



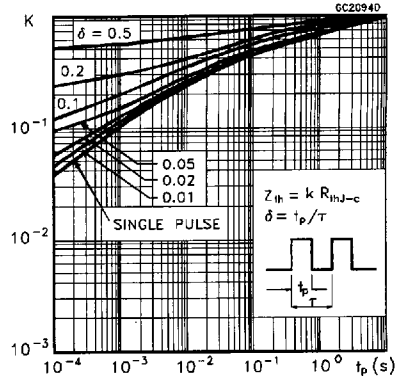
**Safe Operating Areas For ISOWATT220**



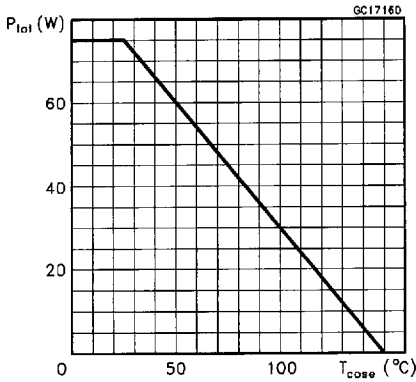
Thermal Impedance For TO-220



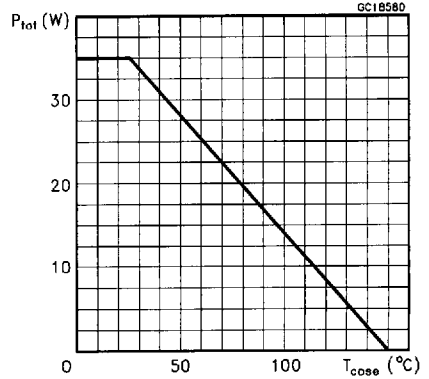
Thermal Impedance For ISOWATT220



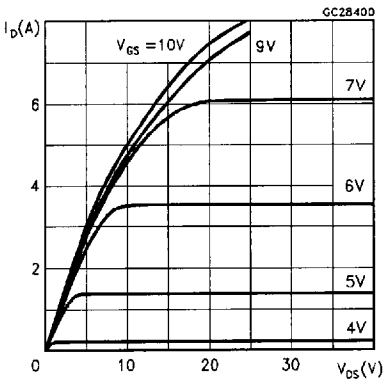
Derating Curve For TO-220



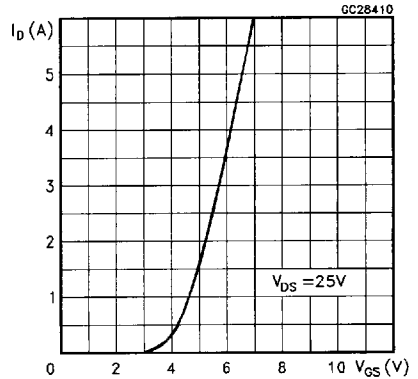
Derating Curve For ISOWATT220



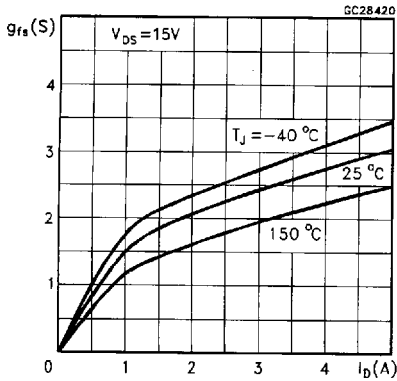
Output Characteristics



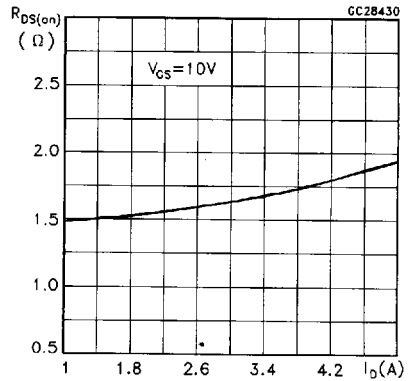
Transfer Characteristics



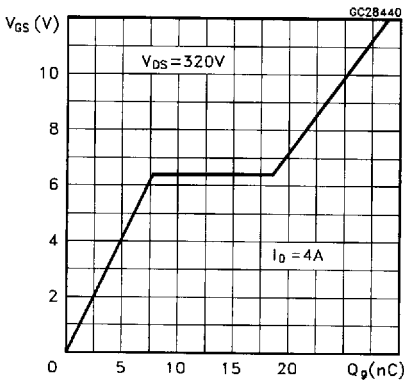
Transconductance



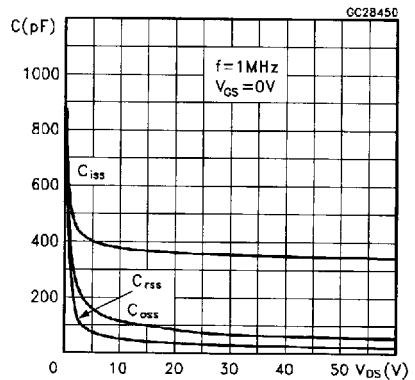
Static Drain-source On Resistance



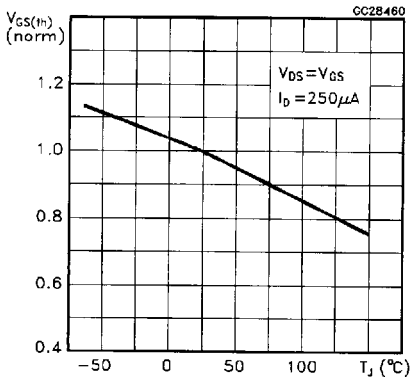
Gate Charge vs Gate-source Voltage



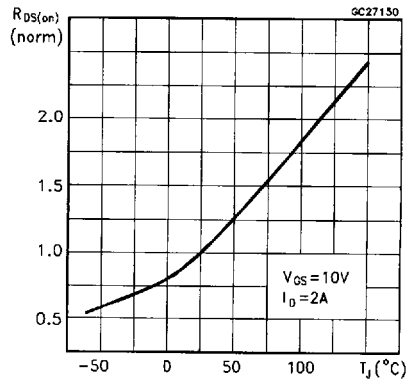
Capacitance Variations



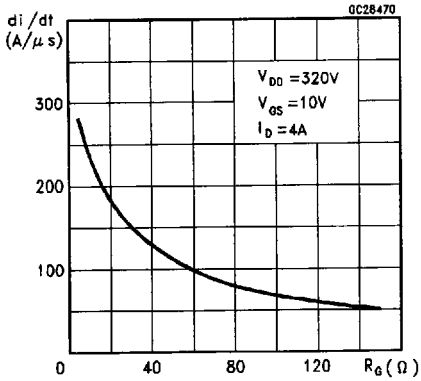
Normalized Gate Threshold Voltage vs Temperature



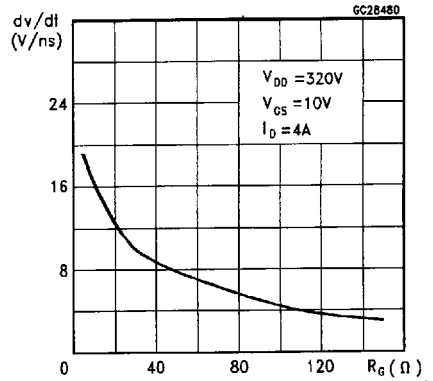
Normalized On Resistance vs Temperature



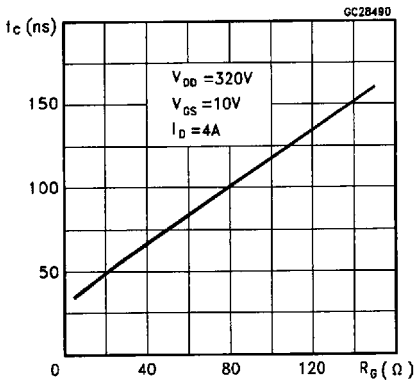
Turn-on Current Slope



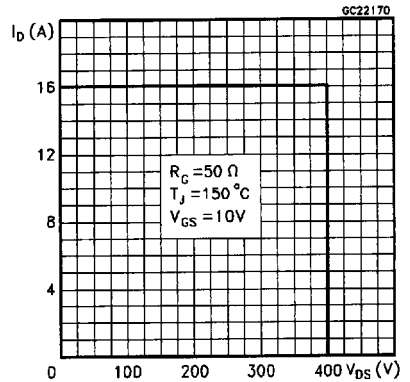
Turn-off Drain-source Voltage Slope



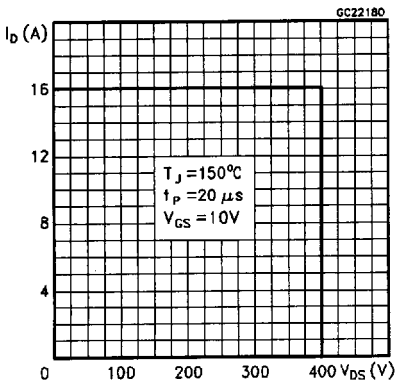
Cross-over Time



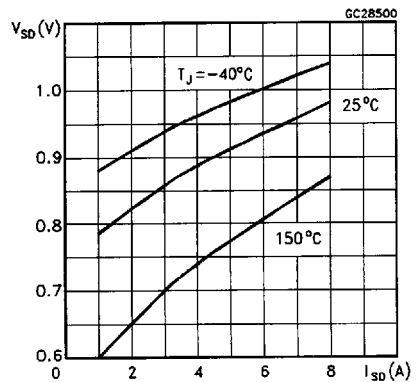
Switching Safe Operating Area



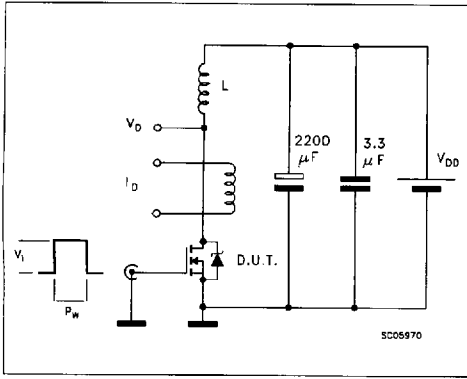
Accidental Overload Area



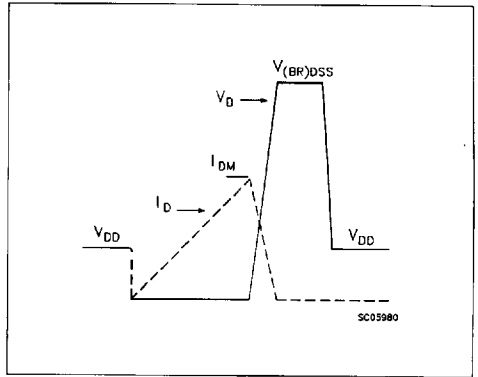
Source-drain Diode Forward Characteristics



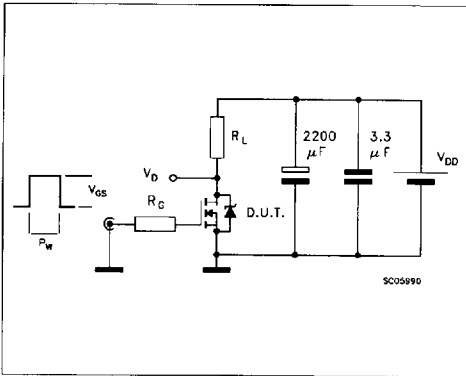
**Fig. 1: Unclamped Inductive Load Test Circuits**



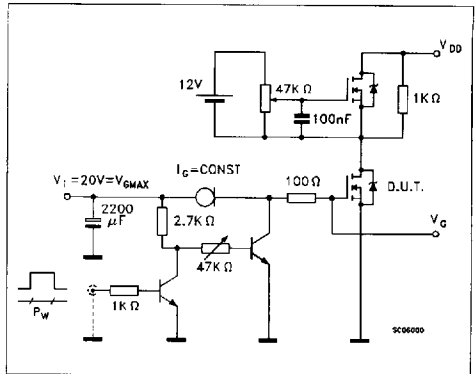
**Fig. 2: Unclamped Inductive Waveforms**



**Fig. 3: Switching Times Test Circuits For Resistive Load**



**Fig. 4: Gate Charge Test Circuit**



**Fig. 5: Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time**

